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# Deep-UV fluorescence lifetime imaging microscopy

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A novel fluorescence lifetime imaging microscope (FLIM) working with deep UV 240-280 nm wavelength excitations is developed. UV-FLIM is used for measurement of defect related fluorescence and its changes upon annealing from femtosecond laser-induced modifications in fused silica. This FLIM technique can be used with micro-fluidic and bio-samples to characterize temporal characteristics of fluorescence upon UV excitation, a capability easily added to a standard microscope-based FLIM. UV-FLIM was tested to show an annealing of the defects induced by silica structuring with ultra-short laser pulses. Frequency-domain fluorescence measurements were converted into the time-domain to extract long fluorescence lifetimes from defects in silica.

Femtosecond laser direct writing is a powerful technique with applications ranging from optofluidics and optomechanics [1–3] to birefringent optical elements [4] and optical data storage [5]. Under certain experimental conditions, femtosecond laser irradiation can induce self-assembled nanostructure in the bulk of transparent material [6–8] or imprint complex polarization fields onto surface [9–11]. The sub-wavelength arrangement of this modification results in an optical anisotropy - the form birefringence - which provide control over polarization of traversing light, hence, polarization controlling optical elements can be made using nano-gratings. The nanogratings are observed only in a handful of materials such as sapphire, tellurium oxide, germanium oxide and silica glasses. The mechanisms of nano-grating and surface ripple formation are closely related and are actively researched (for a recent review ref. [11]). The bulk ripples are formed at sub-critical free carrier plasma densities; the breakdown occurs at the permittivity  $\varepsilon' = 0$  (real part) when the critical plasma density is reached. At a higher excitation and over-critical plasma densities when  $\varepsilon' \leq -1$  a surface wave - the surface plasmon polariton - can be formed which is imprinted onto the surface by ablation [11]. In both cases of the bulk and surface ripples the period is closely following  $\Lambda = \lambda_0/n(I)/2$ , where the refractive index n is intensity, I, dependent and  $\lambda_0$ is the light wavelength in vacuum [11].

Formation of the nanostructure in dielectrics is accompanied by the rearrangement of chemical bonds and

formation of optically, magnetically, and electrically active defects. Some of them, under UV irradiation, emits strong fluorescence detectable from the laser-structured areas that can strongly impede imaging and fluorescence lifetime measurements popular in bio- and medical- research. The fluorescence lifetime imaging microscopy (FLIM) has become a popular technique in cell imaging and is used for investigation of energy transfer mechanisms and can deliver a super-resolution capability [12–14]. Addition of UV functionality to FLIM is a very appealing direction due to a possibility of direct excitation of proteins [15] without their labeling. Further insights into germicidal properties of deep-UV (240-280 nm) light [16–18] could be achieved with UV-FLIM. LEDs are used in FLIM, however not in deep UV range [19].

Here, we show the UV capability which can be added to standard microscope-based FLIM setups. This UV-FLIM functionality is demonstrated by fluorescence analysis of laser-induced defects in silica where polarization converters were formed by fs-laser writing. It is shown that annealing at 300°C for 2 h fully removes the fluorescence at 650 nm and longer wavelengths without suppressing the form birefringence required for polarization conversion. The UV-fluorescence-lifetime-imaging method revealed the removal of long-time relaxation components from the fluorescence time decay in defect-fluorescence band in silica. This expands use of fluorescence under UV excitation demonstrated for recognition of protein crystals [20].

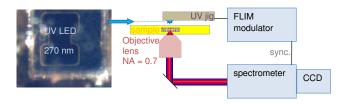


Fig. 1. Realization of UV-FLIM with UV-LED emitting at 270 nm. Custom designed LED controller (UV-jig) was synchronized with FLIM electronics. Samples used: cells, water dissolved dyes in micro-fluidic capillary, laser structured regions inside silica glass. Footprint of the LED (left) was  $2\times 2~\mathrm{mm}^2$ .

### 1. Method

The frequency domain realisation of fluorescence lifetime imaging microscopy is based on the temporal modulation of the excitation and on the synchronized detection of the phase-shifted signal [12–14]. To characterize the temporal properties of fluorescence, the frequency-domain approach was utilized, wherein the lifetime is determined from the phase,  $\phi$ , and modulation, M, of the fluorescence signal. Typical phasor presentation A vs. B is a convenient method to show the phase and modulation values:

$$B = M\cos(\phi), \quad A = M\sin(\phi).$$
 (1)

This method is well suited to measure fluorescence of dye - nanoparticle mixtures in water solutions [21] and is extended to measure the fluorescence from the defects in solid state materials.

Phase modulation implemented in the FLIM measurements allows much broader time-resolution and more detailed information on the fluorescence transients as compared with the standard pump-probe measurements which usually cannot cover such a vast span of lifetimes. Additionally, UV-FLIM measurements provide information with spatial resolution of 2-3  $\mu$ m using standard microscopy setup.

The UV-LED-Controller (OptoTech Pty Ltd) tunes the duty cycle of the LED emission from 1 to 1/10 for repetition rates up to 1 MHz. Thanks to this modality, the maximum current can be as high as 20 mA for the light emission duration of the cycle. Deep-UV LEDs at 250-290 nm wavelength (SET, Inc.) spectral range were used to excite fluorescence form micro-particles [22]. UV-LED controller, power supply, and housing are all combined into a compact jig which can be placed directly onto a microscope objective; the size of a portable jig was  $135 \times 45 \times 25 \text{ mm}^3$   $(l \times w \times h)$ .

FLIM data acquisition and analysis were carried out with a commercial setup (LIFA, Lambert Instruments). Signal to noise ratio in fluorescence detection was up to

10<sup>3</sup> and allowed to explore broad dynamic range of decay times. All data were taken after a high fidelity (within a confidence range of 0.98) fit of experimental data using the least square iterative re-convolution based on the minimization of the weighted sum of the residuals implemented in the Lambert Instruments software. This procedure was carried for multi-exponential fits at up to 10 modulation frequencies. Sampling rate and acquisition times were chosen by software to reach the requested high fidelity fits at each frequency. All multi-frequency acquisition was taking up to few minutes.

### 2. RESULTS

In the experiments, the UV-FLIM setup was realized on the basis of a commercial FLIM setup (LIFA, Lambert Instruments) as is shown in Fig. 1. The UV LED excitation source was placed directly onto the microscope sample stage for illumination of sample. Leads of a standard TO-18 can housing of the UV-LED were shortened to reduce the RC-constant and to achieve high LED switching rates. LED was placed on laser fabricated sample directly without any collimation optics and was used at maximum average power of several microwatts (current of 20 mA).

The FLIM measurements were performed on femto second laser written polarization converters (Fig. 2) designed for 532 nm wavelength [4]. The converters have an azimuthally varying pattern of nano-gratings which defines the optical function of the converter. Such converters are the q-plates [23] - inhomogeneous birefringent plates with a topological defect of charge q for the azimuthal pattern of the optical axis. The azimuthal dependence of the slow axis is given by  $\Psi = q\varphi$ , here q is the half-integer and  $\varphi$  the polar angle. The q-plates are used to control the spin-orbital conversion of beams and have an increasing number of applications from microfluidics to quantum computing (see, review ref. [24]). The polarization converters - q-plates used in this study are made small for integration into a micro-fluidic channel and realization of (i) an opto-mechanical momentum transfer element or (ii) structured light illumination of micro-particles in the channel.

# 2.A. Fluorescence from pol.-converters illuminated by deep-UV LEDs

Under illumination of the polarisation converter with a 474 nm laser diode at several tens-of-mW power light, a strong red fluorescence could be detected, which can be attributed to the non-bridging oxygen hole center (NBOHC) emission at 650 nm [25] as shown in Fig. 2. Since the form birefringence exhibited by nano-gratings is spectrally broadband, the fluorescence at wavelengths longer than  $\lambda_l = 560$  nm (a long-pass filter) shows an intensity distribution with a peculiar reminiscence of a phase pattern typical to an optical vortex. This is caused by polarization dependence of the fluorescence excitation and emission due to the presence of the nanogratings. The form-birefringent nano-gratings are creating the same pattern of the defects in silica. The lin-

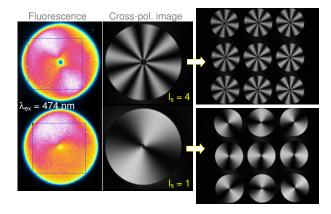


Fig. 2. (from left to right) Fluorescence (false color) image after a long-pass filter  $\lambda_l=560$  nm; the excitation wavelength was  $\lambda_{ex}=474$  nm. Cross-polarized images under white light illumination revealing the polarization converters of charge  $l_s=4$  (upper) and  $l_s=1$  (lower). Arrays of polarization converters  $3\times 3$  of different charges and with different orientations were recorded in a silica glass piece that forms the base of a microfluidic channel; the converters diameter is  $600~\mu m$ .

early polarized LED illumination of such nano-gratings creates a fluorescence emission following an angular intensity distribution pattern according to  $I_f \propto \cos\theta^2$ , where  $\theta$  is the angle between polarization and the orientation (the wavevector) of the nano-gratings. As a result, fluorescence intensity has azimuthal distribution, which might be unwanted in fluorescence measurements. It is noteworthy, the ripple period is affected by the thermal conductivity (temperature diffusivity) which becomes anisotropic along and across the ripples during writing [26]. As a result, thermal accumulation affects the ripple pattern which is dependent on the writing sequence and proximity of already structured regions. Accordingly, the defect fluorescence becomes dependent on the way of recording of ripple patterns.

Figure 3 shows the emission spectra of the 270 nm LED measured in air and through the microscope. Freeair emission of the LED has a peak centered at 274 nm and its second order diffraction is at exactly 548 nm. When the same emission is measured through the FLIM microscope, a broader emission  $530 \pm 50$  nm is observed in the eye-piece of the microscope and spectrometer. In this case due to filtering of UV component by microscope optics, this emission is related mainly to the defects in LED and partially due to microscope optics. A good image of the LED taken with the microscope suggests that fluorescence originated mainly from the LED which was placed at the focus (see, inset). When polarization converter is illuminated by the 270 nm LED by placing it on to glass above the laser structured regions, a reddish emission band around 670 nm is recognizable. This

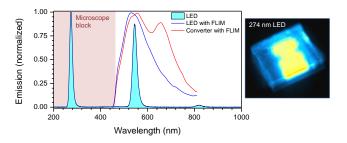


Fig. 3. Emission spectra from the 270 nm LED with peak at 274 nm and its higher order diffractions at 548 nm and 822 nm measured without microscope optics, emission of the same LED detected with FLIM microscope, and emission detected from the polarization converter in silica illuminated by the LED. The shaded region marks the wavelengths that are blocked by the microscope optics. The inset shows a false color image (representing intensity) of LED taken with the FLIM setup.

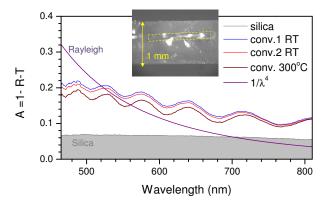


Fig. 4. Absorbance, A, spectra of pol.-converters as fabricated (at room temperature RT) and annealed at 300°C for 2 h; transmission  $T=10^{-OD}=e^{-\alpha d}$ , where d is thickness and  $\alpha$  (cm<sup>-1</sup>) is the absorption coefficient. The spectral range is defined by FLIM microscope transmission band. Thickness of glass was d=1 mm and optical thickness of nano-gratings (pol.-convertor)  $d_c\simeq 72~\mu{\rm m}$  (dashed-box encloser in the inset). The Rayleigh scattering spectral profile is given by  $\lambda^{-4}$ ; R+T+A=1 with R accounting for reflection losses.

band is related to non-bridging oxygen hole center Si-O-emission (NBOHC; · is the dangling bond) [25, 27, 28]. The fluorescence image like shown in Fig. 2 can be obtained under few microwatts excitation at this deep-UV radiation due to emission from NBOHC defects.

# 2.B. Post-annealing optical characterization of pol.-converters

After annealing of converters from 100 to 300°C their scattering is slightly decreased and defect-related fluorescence at 650 nm NBOHC band was fully erased (Figure 4). The optical density (OD) spectrum showed only a slight reduction of the losses within the spectral window of the FLIM microscope. Annealing at 300°C for 1 h is sufficient to erase the defect-related emission in silica. [25, 27] The residual losses are attributed to scattering in nano-gratings.

Interference fringes (Fig. 4) are the signature of the nano-gratings which have recognizable (an optical sideview imaging was used) thickness of  $d_c \simeq 70~\mu \mathrm{m}$ . One can obtain comparable value from the two neighboring interference maxima at wavelengths  $\lambda_{1,2} = 526,576~\mathrm{nm}$  from  $\Delta nd = (1/\lambda_1 - 1/\lambda_2)^{-1}$ , where  $\Delta n \simeq 8.4 \times 10^{-2}$  is the refractive index of silica and  $d = 72~\mu \mathrm{m}$  is the apparent thickness of the pattern responsible for interference (thickness of polarization converter). This value is larger than usual modulation of refractive index due to nano-grating which is approximately  $\Delta n \sim 10^{-3}$ . Possibly, the actual extension of the polarization converter is larger than can be judged from the obvious breakdown regions from side observation. [28–31]

# 2.C. FLIM measurements from defects in silica

From the phase  $\phi$  and modulation M using a phasor plot A = f(B) the fluorescence lifetime  $\tau$  is determined. By selecting different modulation frequencies in the range of f = 0.1 - 10 MHz the lifetime as short as  $\sim 1$  ns can be retrieved. Figure 5(a) shows raw experimental data and sin-fit which was used to calculate the phase and modulation of the detected emission at a single fixed modulation frequency. For multi-exponential decay processes a single modulation frequency is insufficient to resolve multiple lifetime decays. Consequently, we determined the phase and modulation values at 10 different modulation frequencies. Figure 5(b) displays the phase and modulation values as a function of modulation frequency for the polarization converters. The solid lines are fits to the dispersion equations appropriate for a multi-exponential decay model [32].

Fits are summarised in Fig. 6. To aid visualisation of the decay processes in time, the fits to the phase-modulation data are presented in the time-domain in Fig. 6.

Fluorescence of the defects usually has a complex stretched exponential behavior. From the FLIM data the time dependence of fluorescence is expressed by multi-exponential expression with a characteristic time  $\tau_i$  and corresponding amplitude  $a_i$  as:

$$Fluorescence(t) = \sum_{i=1}^{n} \frac{a_i}{\tau_i} e^{-\frac{t}{\tau_i}}.$$
 (2)

We used maximum n=5 for the best fit of the measured FLIM data from the defects in glass. Data are

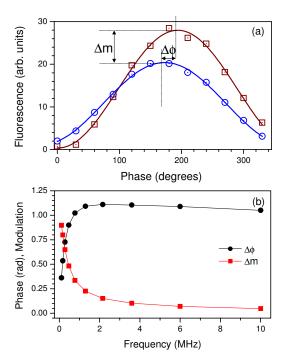


Fig. 5. (a) The phase shifted and modulated FLIM signals from the rhodamine ( $\square$ ) and pol.-convertor ( $\bigcirc$ ). The phase shift  $\Delta\phi$  and change of modulation depth  $\Delta m$  are shown. The best fit to a sin-function was used to extract the lifetime  $\tau$  at a specific 0.1 MHz frequency. Fluorescence intensity error bars < 5% were smaller than the marker size. (b) Phase and modulation data from pol.-converter. Solid lines represent the best fit to a multiple lifetime model; this representation corresponds to the Fourier transform of the time domain dependence given by eqn. 2.

summarized in Fig. 6. Under standard FLIM excitation  $\lambda_{ex}=474$  nm the effect of annealing is clearly seen. We observed a slight increase of fluorescence intensity after annealing up to  $100^{\circ}$ C and a slight change in the decay profile, however, changes were minimal and usually within the uncertainty range of measurements. Such behavior can be explained by defects relaxation [33, 34] since fs-laser fabrication is capable to quench meta-stable states of defects with low activation energy. [35]

Annealing up to 300°C degrees was sufficient to strongly decrease fluorescence at times longer than 100 ns consistent with silica defect relaxation time [27]. It was demonstrated earlier that such annealing preserves the form birefringence of laser structures regions since the nano-gratings remain intact [36]. A temperature of 300°C degrees corresponds to the activation energy of  $E_a=0.78~{\rm eV}$ .

Under a 270 nm UV LED excitation, the optics of FLIM microscope was acting as a filter (Fig. 3) with very fast decay times (Fig. 6(b)). Since UV FLIM has never been used before, we tested it on Rhodamine 6G

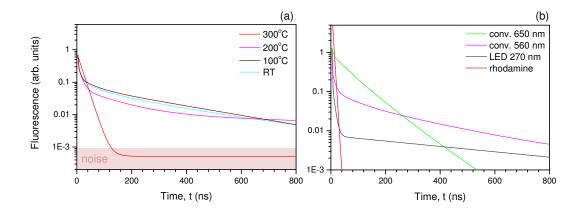


Fig. 6. Multi-frequency multi-exponential fit of frequency domain FLIM (Fig. 5) using Eqn. 2.(a) Fluorescence transients of pol.-converter  $l_s=2$  annealed at different temperatures. Excitation wavelength is  $\lambda_{ex}=474$  nm. (b) Fluorescence time decay under  $\lambda_{ex}=270$  nm excitation. Rhodamine 6G showed a  $\tau\simeq 4$  ns decay. Pol.-converter fluorescence was filtered by band-pass (550 ±20 nm) and long-pass (560 nm) filters. The direct emission from LED 270 nm measured by FLIM is also presented.

and obtained results very close to the single exponential decay of  $\tau \simeq 3.97$  ns as for the reference solution from Lambert Instruments. This expected value shows that UV-FLIM can be used with standard dyes. The fluorescence was filtered in two different spectral bands for which different transients were observed. Since under 274 nm excitation wavelength, a wider spectrum of defects is expected to be excited, such filter-gating of emission bands provides tool to characterize the defects induced by fs-laser fabrication. Stretched exponential time decay of the defect-related luminescence is standard in solid state materials, especially, in glasses where electron-hole separation and trap energy positions vary.

# 3. DISCUSSION

It is expected that UV-FLIM combination with Raman scattering spectroscopy will provide deeper insights into defect and morphological modifications occurring within and around the fs-laser structured volumes. This is a key for fabrication of micro-optical elements and waveguides where local mass density and defects are critically important for the designed function and longevity [37–39]. Better understanding of fs-laser structuring is still strongly required as it can deliver unique new materials [40–42].

Advantages of the frequency-domain deep UV-LED FLIM system is in its considerably lower cost than multiphoton pulsed laser systems or continuum fibre lasers. Frequencies can be tuned to match longer lived luminescence transients which would be not practical to measure using time domain methods due to the required long delay lines.

# 4. CONCLUSIONS AND OUTLOOK

UV-FLIM setup based on a commercial FLIM microscope is demonstrated and extends excitation wavelengths to the shortest 240 nm-wavelength available

among the state-of-the-art UV LEDs. The spectral bandwidth of the detection path was defined by the microscope; synchronization of UV-LED with FLIM setup was realized by a custom built controller, which is small enough to place the illumination directly onto a sample mounted on a microscope stage. By controlling the duty cycle of UV illumination, the dedicated electronics allows a pulsing operation of the UV-LED with pulse duration down to 20 ns. This setup can be integrated to illuminate microfluidics channels in UV-transparent silica chips or tubes.

Potential use of UV-FLIM for defect characterization in fs-laser structured materials is demonstrated revealing stretched exponential temporal transients. This technique is also promising in bio-medical research since it delivers the capability to use FLIM in frequency domain with light sources which directly excite proteins by absorption at  $\lambda_{ex} < 280$  nm. Since UV-LEDs are widely used in water disinfection, a FLIM capability can provide further information on the effectiveness of the delivered UV dose in incapacitating bacterial, microbial, and viral agents. The UV-FLIM capability can be combined with imaging mode for samples with spatially variant fluorescence lifetime features.

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Contributions: CJdJ and AJ carried out experiments and primary data analysis, MG and MB fabricated optical vortex generators, GG made first proof-of-the-concept experiments on instrumental capability of deep-UV excited fluorescence, CJdJ and AHAC worked out methodology of experiments and carried out detailed data analysis, PGK and YB analyzed and discussed the data, AHAC and SJ conceived an UV-FLIM idea. All the authors contributed to drafting and editing the manuscript.